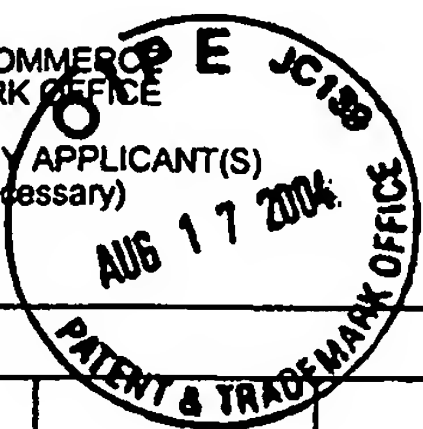


FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. 03500.007991.1		APPLICATION NO. 10/665,409	
			APPLICANT SHIGERU TAKESHITA, ET AL.			
			FILING DATE September 22, 2003		GROUP 2622-2621	
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>HW</i>	5,764,848	06/09/98	Suga et al.	358	906	
<i>HW</i>	5,309,247	05/03/94	Knoshita et al.	358	909.1	
<i>HW</i>	5,200,863	04/06/93	Orii	360	35.1	
<i>HW</i>	5,170,262	12/08/92	Kinoshita et al.	358	335	
<i>HW</i>	5,153,730	10/06/92	Nagasaki et al.	358	909	
<i>HW</i>	5,134,487	07/28/92	Taguchi et al.	358	906	
<i>HW</i>	5,099,364	03/24/92	Kawabata	358	906	
<i>HW</i>	5,067,029	11/19/91	Takahashi et al.	358	335	
<i>HW</i>	5,057,925	10/15/91	Tsutsui et al	348	906	
<i>HW</i>	5,053,861	10/01/91	Tsai et al.	348	231	
<i>HW</i>	5,016,124	05/14/91	Fukushima et al.	358	906	
<i>HW</i>	5,016,107	05/14/91	Sasson et al.	358	906	
<i>HW</i>	4,945,424	07/31/90	Hiroki et al.	358	906	
<i>HW</i>	4,928,137	05/22/90	Kinoshita	355	906	
<i>HW</i>	4,768,110	08/30/88	Dunlap et al.	360	33.1	
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER <i>HW</i>			DATE CONSIDERED <i>11/16/2007</i>			

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			FILING DATE September 22, 2003		GROUP 2622 2621	

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U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>HM</i>		4,456,931	06/26/84	Toyoda et al.	358	335	
<i>HM</i>		3,811,090	05/14/74	Uchida et al.	348	730	

FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
<i>HM</i>		356,351	02/90	Europe			
<i>HM</i>		336,317	10/89	Europe			
<i>HM</i>		01-109882	04/89	Japan			Abstract
<i>HM</i>		01-101079	4/89	Japan			Abstract
<i>HM</i>		64-16081	1/19/89	Japan			Abstract
<i>HM</i>		59-64975	04/13/84	Japan			Abstract

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)		

EXAMINER <i>Greg Meyer</i>	DATE CONSIDERED <i>11/16/2007</i>
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